

# INTERNATIONAL STANDARD

**IEC**  
**60738-1-4**

QC 440004

First edition  
1998-12

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**Thermistors –  
Directly heated positive step-function  
temperature coefficient –**

**Part 1-4:  
Blank detail specification –  
Sensing application –  
Assessment level EZ**

*Thermistances à basculement à coefficient de température  
positif à chauffage direct –*

*Partie 1-4:  
Spécification particulière cadre –  
Application pour la mesure de température –  
Niveau d'assurance EZ*



Reference number  
IEC 60738-1-4:1998(E)

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## Terminology, graphical and letter symbols

For general terminology, readers are referred to IEC 60050: *International Electrotechnical Vocabulary* (IEV).

For graphical symbols, and letter symbols and signs approved by the IEC for general use, readers are referred to publications IEC 60027: *Letter symbols to be used in electrical technology*, IEC 60417: *Graphical symbols for use on equipment. Index, survey and compilation of the single sheets* and IEC 60617: *Graphical symbols for diagrams*.

\* See web site address on title page.

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Commission Electrotechnique Internationale  
International Electrotechnical Commission  
Международная Электротехническая Комиссия

PRICE CODE

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# INTERNATIONAL ELECTROTECHNICAL COMMISSION

## THERMISTORS –

### DIRECTLY HEATED POSITIVE STEP-FUNCTION TEMPERATURE COEFFICIENT –

#### Part 1-4: Blank detail specification –

#### Sensing application –

#### Assessment level EZ

### FOREWORD

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International Standard IEC 60738-1-4 has been prepared by IEC technical committee 40: Capacitors and resistors for electronic equipment.

The text of this standard is based on the following documents:

FDIS	Report on voting
40/1084/FDIS	40/1100/RVD

Full information on the voting for the approval of this standard can be found in the report on voting indicated in the above table.

The QC number that appears on the front cover of this publication is the specification number in the IEC Quality Assessment System for Electronic Components (IECQ).

**THERMISTORS –  
DIRECTLY HEATED POSITIVE STEP-FUNCTION  
TEMPERATURE COEFFICIENT –**

**Part 1-4: Blank detail specification –**

**Sensing application –**

**Assessment level EZ**

## INTRODUCTION

### Blank detail specification

A blank detail specification is a supplementary document to the generic specification and contains requirements for style and layout and minimum content of detail specifications. Detail specifications not complying with these requirements shall not be considered as being in accordance with IEC specifications nor shall they so be described.

In the preparation of detail specifications the content of 1.4 of the generic specification shall be taken into account.

The numbers between brackets on the first page correspond to the following information which shall be inserted in the position indicated.

### Identification of the detail specification

- [1] The "International Electrotechnical Commission" or the National Standards Organization under whose authority the detail specification is drafted.
- [2] The IEC or National Standards number of the detail specification, date of issue and any further information required by the national system.
- [3] The number and issue number of the IEC or national generic specification.
- [4] The IEC number of the blank detail specification.

### Identification of the thermistor

- [5] A short description of the type of thermistor.
- [6] Information on typical construction (if applicable).

NOTE – When the thermistor is not designed for use on printed boards, this should clearly be stated in the detail specification in this position.

- [7] Outline drawing with main dimensions which are of importance for interchangeability and/or reference to the national or international documents for outlines. Alternatively, this drawing may be given in an annex to the detail specification.
- [8] Application or group of applications covered and/or assessment level.
- [9] Reference data on the most important properties, to allow comparison between the various thermistor types.

[1]	IEC 60738-1-4-XXX QC 440004	[2]
ELECTRONIC COMPONENTS OF ASSESSED QUALITY IN ACCORDANCE WITH:	IEC 60738-1-4 QC 440004	[4]
[3]	DIRECTLY HEATED POSITIVE STEP-FUNCTION TEMPERATURE COEFFICIENT THERMISTORS FOR SENSING APPLICATION	[5]
Outline drawing: [see 1.2] [... angle projection]	MODIFIED FERRO-ELECTRIC CERAMIC MATERIAL	[6]
[7] [Other shapes are permitted within the dimensions given]	Assessment level: EZ	[8]

[9]  
Information on the availability of components qualified to this detail specification is given in the Register of Approvals.

## 1 General data

### 1.1 Method(s) of mounting (to be inserted)

(See 4.12.1 of IEC 60738-1.)

### 1.2 Dimensions

(All dimensions are in millimetres or inches and millimetres; it shall be stated which dimensions are suitable for gauging.)

Dimensioned drawing(s) shall be given in the detail specification. If necessary, the dimensions may be listed in tabular form with reference to styles or codes.

### 1.3 Coating

The detail specification shall state:

- a) whether the coating is insulating or non-insulating;

- b) the material;
- c) the colour, if applicable.

#### 1.4 Terminations

The detail specification shall state whether the terminations are suitable for soldering. If they are not, suitable methods of connection shall be stated for example: welding, clamping or crimping.

#### 1.5 Flammability

The detail specification shall state whether the thermistor is actively or passively flammable if applicable. The test method shall be given in the test schedule.

#### 1.6 Resistance to solvents

The detail specification shall state whether the coating and the marking of the thermistor are solvent resistant if applicable. The test methods shall be given in the test schedule.

#### 1.7 Packaging

The detail specification shall give the following information (if required):

- a) whether bulk packed or taped and if taped, drawing or references;
- b) the dimensions of the immediate packaging and the number of thermistors packed;
- c) the dimensions of the outer package and the number of immediate packages;
- d) methods of disposal of the packaging material.

#### 1.8 Electrical data/Ratings and characteristics

The detail specification shall give units and tolerances or limiting values for the following parameters. If necessary, electrical data may be listed in tabular form, with reference to styles and codes.

Upper/Lower category temperatures (UCT/LCT);

Operating temperature range at maximum voltage;

Maximum voltage ( $U_{\max}$ );

Zero-power resistance ( $R_T$ );

Resistance  $R_{NF}$  at  $T_{NF}$  (if applicable);

Isolation voltage (insulated thermistors only);

Insulation resistance (insulated thermistors only);

Response time.

#### 1.9 Related documents

Generic specification:

IEC 60738-1:1998, *Thermistors – Directly heated positive step-function temperature coefficient – Part 1: Generic specification*

#### 1.10 Marking

The marking of the thermistors and package containing the thermistors shall be in accordance with the requirements of 2.4 of IEC 60738-1.

The details of the marking of the thermistors and package containing the thermistor shall be given in full in the detail specification.

### 1.11 Ordering information

Orders for thermistors covered by this specification shall contain, in clear or in coded form, the following minimum information:

- a) style reference;
- b) maximum continuous a.c. voltage;
- c) number and issue reference of the detail specification.

### 1.12 Additional information (not for inspection purposes)

### 1.13 Additional or increased severities or requirements to those specified in the generic sectional specification

NOTE – Additions or increased requirements should be specified only when essential.

## 2 Inspection requirements

### 2.1 Procedures

**2.1.1** For qualification approval, the procedures shall be in accordance with the generic specification, IEC 60738-1, 3.5.

**2.1.2** For quality conformance inspection, the test schedules (tables 1 and 2) include sampling, periodicity, severities and requirements. The formation of inspection lots is covered by 3.12 of the generic specification.

The following list applies to the test schedules developed in tables 1 and 2:

- 1) Subclause numbers of tests and performance requirements refer to the generic specification IEC 60738-1 and clause 1 of this specification.
- 2) Number to be tested: sample size as directly allotted to the code letter for IL in table IIA of IEC 60410 (Single sampling plan for normal inspection).
- 3) In these tables:
  - p is the periodicity (in months)
  - n is the sample size
  - c is the acceptance criterion (permitted number of non-conforming items)
  - D indicates a destructive test
  - ND indicates a non-destructive test
  - IL is the inspection level
- 4) The temperature at which the zero-power resistance shall be measured is the temperature specified in the detail specification. This temperature shall be stated, where required, in the test schedule.
- 5) The specimens used for this group may, at the discretion of the manufacturer, be used for any subsequent group which is identified as being "destructive".
- 6) The soldering – solderability and soldering – resistance to heat tests shall only be applied where the thermistor has terminations which are appropriate for soldering.
- 7) Where the terminations are stated to be suitable for printed wiring applications, the appropriate test conditions in IEC 60068 shall apply.
- 8) The thermistors shall be mounted by their normal means.
- 9) The bump test and the shock test are alternatives. The test selected in the detail specification shall be used.

- 10) The detail specification shall specify which of the endurance tests in groups C4, C5 and D1 respectively are appropriate to the construction and application of the thermistor.
- 11) Any deviation from annex B of the generic specification shall be given in the detail specification.
- 12) 100 % testing shall be followed by re-inspection by sampling in order to monitor outgoing quality level by non-conforming items per million ( $\times 10^{-6}$ ). The sampling level shall be established by the manufacturer. For the calculation of  $\times 10^{-6}$  values any parametric failure shall be counted as a non-conforming item. In case one or more non-conforming items occur in a sample, this lot shall be rejected.

**Table 1 – Test schedule for quality conformance inspection: lot-by-lot**

Subclause number and test (see list item 1)	D or ND	Conditions of test (see list item 1)	(see list item 3)			Performance requirements (see list item 1)
			IL	n	c	
<b>GROUP A INSPECTION</b> (lot-by-lot)						
<b>Subgroup A0</b>	ND			100 % (see list item 12)		As in 4.5.3
4.5 Zero-power resistance $R_T$		Temperature: ... °C Voltage: ... V Frequency: ... Hz (if applicable)				
<b>Subgroup A1</b>	ND		S-4	<sup>2)</sup>	0	As in 4.4.1
4.4.1 Visual examination						
<b>Subgroup A2</b>	ND		S-3	<sup>2)</sup>	0	As in 4.4.2
4.4.2 Marking						
4.4.3 Dimensions (gauging)						As specified in the detail specification
<b>GROUP B INSPECTION</b> (lot-by-lot)						
<b>Subgroup B1</b>	ND		S-2	<sup>2)</sup>	0	As in 4.5.3
4.5 Zero-power resistance $R_T$ (if specified)		Temperature: ... °C Voltage: ... V				As in 4.5.3
Functioning resistance $R_{NF}$ at $T_{NF}$						As in 4.5.3
4.26 Residual current (if specified)						$I_{res} \leq \dots$ mA
<b>Subgroup B2</b>	ND		S-2	<sup>2)</sup>	0	As in 4.8.4
4.8 Voltage proof		(Insulated thermistors only) Method: ... Applied voltage: ... V a.c.				
4.16.1 Soldering - Solderability		(see list item 6 and 7) Solder bath method				The terminations shall be uniformly tinned

**Table 2 – Test schedule for quantity conformance inspection: periodic**

Subclause number and test (see list item 1)	D or ND	Conditions of test (see list item 1)	Sample size and acceptance criterion (see list item 3)			Performance requirements (see list item 1)
			p	n	c	
<b>GROUP C INSPECTION</b> (periodic)						
<b>Subgroup C1A</b>						
D						
(see list item 6 and 7)						
6 5 0						
<b>Part of sample</b>						
4.16.2		Soldering – resistance to soldering heat				As in 4.16.2 $\Delta R/R$ : from ... % to ... %
4.15		Robustness of terminations				As in 4.15.4 $\Delta R/R$ : from ... % to ... %
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<b>Subgroup C1B</b>						
D						
6 5						
<b>Other part of sample</b>						
4.17		Rapid change of temperature				As in 4.17 $\Delta R/R$ : from ... % to ... %
4.18		Vibration				As in 4.18 $\Delta R/R$ : from ... % to ... %
4.19		Bump (or shock, see list item 9)				As in 4.19 $\Delta R/R$ : from ... % to ... %

Table 2 (continued)

Subclause number and test (see list item 1)	D or ND	Conditions of test (see list item 1)	Sample size and acceptance criterion (see list item 3)			Performance requirements (see list item 1)
			p	n	c	
4.20 Shock (or bump, see list item 9)		Pulse shape: halfsine Acceleration: ... m/s <sup>2</sup> (see list item 8) Pulse duration: ... ms Visual examination Zero-power resistance (Temperature: ... °C) (Voltage: ... V)				As in 4.20 $\Delta R/R$ : from ... % to ... %
<b>Subgroup C1</b>  <b>Combined sample of specimens of subgroups C1A and C1B</b>	D		6	10		
4.21 Climatic sequence  – Dry heat – Damp heat, cyclic, first cycle – Cold – Damp heat, cyclic, remaining cycles – Final measurements		(Low air pressure test not applicable)  Visual examination Zero-power resistance (Temperature: ... °C) (Voltage: ... V)  Insulation resistance (Insulated thermistors only) Voltage proof (Insulated thermistors only)				As in 4.21.7 $\Delta R/R$ : from ... % to ... %  $R \geq \dots \text{ M}\Omega$ As in 4.21.7
<b>Subgroup C2</b>	ND		6	10	0	
4.11 Response time by ambient temperature $t_a$ (if specified) or 4.12 Response time by power change $t_p$ (if specified)		Method: ... $T_3$ : ... °C $T_1$ : ... °C				Response time: $\leq \dots \text{ s}$  Response time: $\leq \dots \text{ s}$
<b>Subgroup C3</b>	ND	(see list item 5)	6	10	0	
4.6 Temperature coefficient of resistance (if applicable)		$T_p$ : ... °C $T_b$ : ... °C Voltage: ... V				$\alpha_R$ : (from ... to ...) %/K